Application/Control No. Applicant(s)/Patent Under Reexamination 10/042,762 LI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2616 Hanh Nguyen **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY US-6,501,797 B1 12-2002 van der Schaar et al. 375/240.12 Α van Zon, Cornelis 375/240.1 US-7,016,412 B1 03-2006 В US-6,148,005 A 370/469 11-2000 Paul et al. С US-D US-E US-F US-G US-Н USı US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Name Classification Country MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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